

ETR0706-008

#### 2 channel Synchronous Step-Down DC/DC Converter with Manual Reset

### **GENERAL DESCRIPTION**

The XC9515 series consists of 2 channel synchronous step-down DC/DC converters and a voltage detector with delay circuit built-in. The DC/DC converter block incorporates a P-channel  $0.35\Omega$  (TYP.) driver transistor and a synchronous N-channel  $0.35\Omega$  (TYP.) switching transistor. By minimizing ON resistance of the built-in transistors, the XC9515 series can deliver highly efficient and a stable output current up to 800mA. With high switching frequencies of 1MHz, a choice of small inductor is possible. The series has a built-in UVLO (under-voltage lock-out) function, therefore, the internal P-channel driver transistor is forced OFF when input voltage becomes 1.8V or lower (for XC9515A, 2.7V or lower). The voltage detector block can be set delay time freely by connecting an external capacitor. With the manual reset function, the series can output a reset signal at any time.

#### **APPLICATIONS**

DVDs

Blu-ray Disk

LCD TVs, LCD modules

Multifunctional printers

Photo printers

Set top boxes

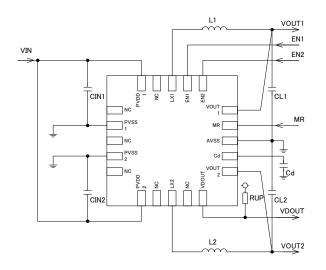
### FEATURES

Package

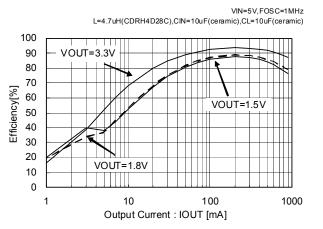
DC/DC Block	
Input Voltage Range	: 2.5V ~ 5.5V
Output Voltage	: V <sub>OUT1</sub> =1.2V ~ 4.0V
	$V_{OUT2}$ =1.2V ~ 4.0V
	(Accuracy ±2%)
Oscillation Frequency	: 1MHz (Accuracy ±15%)
High Efficiency	: 95% (V <sub>IN</sub> =5V, V <sub>OUT</sub> =3.3V)
Output Current	: 800mA
Control	: PWM control
Protection Circuits	: Thermal Shutdown
	: Integral Latch (Over Current Limit)
	: Short Protection Circuit
Ceramic Capacitor Comp	patible
Voltage Detector (VD) E	Block
Detect Voltage Range	: 2.0 ~ 5.5V ( Accuracy ±2% )
Delay Time	: 173 ms
	(When Cd=0.1 µ F is connected)
Output Configuration	: N-channel open drain

: QFN-20

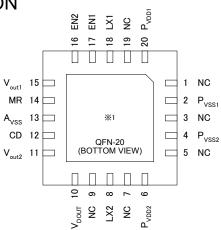
## TYPICAL APPLICATION CIRCUIT



#### TYPICAL PERFORMANCE CHARACTERISTICS Efficiency vs. Output Current



### **PIN CONFIGURATION**



### **PIN ASSIGNMENT**

QFN-20

PIN NUMBER	PIN NAME	FUNCTION	PIN NUMBER	PIN NAME	FUNCTION
1	NC	No Connection	11	V <sub>OUT2</sub>	Output Voltage Sense 2
2	P_V <sub>SS1</sub>	Power Ground 1	12	Cd	Delay Capacitor Connection
3	NC	No Connection	13	$A_V_{SS}$	Analog Ground
4	$P_V_{SS2}$	Power Ground 2	14	MR	Manual Reset
5	NC	No Connection	15	V <sub>OUT1</sub>	Output Voltage Sense1
6	$P_V_{DD2}$	Power Supply 2	16	EN2	CH2 ON/OFF Control
7	NC	No Connection	17	EN1	CH1 ON/OFF Control
8	LX2	Switching Output 2	18	LX1	Switching Output 1
9	NC	No Connection	19	NC	No Connection
10	V <sub>DOUT</sub>	Voltage Detector output	20	$P_V_{DD1}$	Power Supply 1

\*1 Back metal pad voltage  $: V_{SS}$  level

(The back metal pad should be soldered to enhance mounting strength and heat release. If the pad needs to be connected to other circuit, care should be taken for the pad voltage level.)

### **FUNCTION CHART**

EN1, EN2 and MR pins are internally pulled up.  $^{\star 2)}$ 

PIN	LEVEL	OPERATIONAL STATUS		
EN1	High , Open	DC/DC_CH1 Operation		
LINI	Low	DC/DC_CH1 Stop		
EN2	High , Open	DC/DC_CH2 Operation		
EINZ	Low	DC/DC_CH2 Stop		
MR	High , Open	VD_OUT Detect RESET Signal Output		
IVITS	Low	VD_OUT Force RESET Signal Output		

EN1, EN2 and MR pins are internally pulled up so that the levels of High and Open are same function.

EN1, EN2 and MR pins are left open internally.  $^{\star 2)}$ 

PIN	LEVEL	OPERATIONAL STATUS
EN1	High	DC/DC_CH1 Operation
LINI	Low	DC/DC_CH1 Stop
EN2	High	DC/DC_CH2 Operation
LINZ	Low	DC/DC_CH2 Stop
MR	High	VD_OUT Detect RESET Signal Output
IVITS	Low	VD_OUT Force RESET Signal Output

EN1, EN2 and MR pins are floated inside so that these pins shall not be left open outside.

\*<sup>2)</sup> Please refer to the PRODUCTION CLASSIFICATION to see the combination of pull-up status regarding the EN1, EN2, and MR pins.

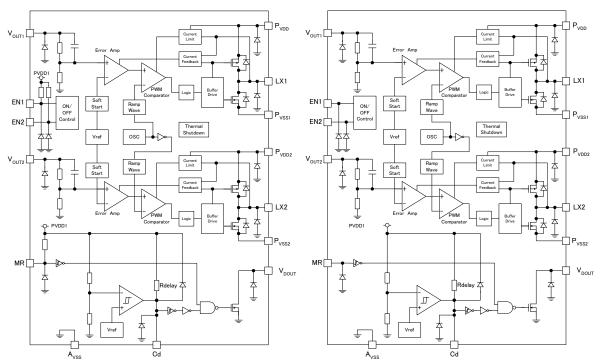
## PRODUCT CLASSIFICATION

Ordering Information (Standard products)

XC9515

DESIGNATOR	DESCRIPTION	SYMBOL	DESCRIPTION
	Input Voltage & UVLO	А	: Input Voltage Range 5V ± 10%, UVLO Voltage 2.7V (TYP.)
	input voltage & 0v20	В	: Input Voltage Range 2.5V ~ 5.5V, UVLO Voltage 1.8V (TYP.)
		A	: EN1, EN2, MR pins are not pulled up internally
		В	: EN1, EN2 pins have built-in pull-up resistors, MR pin has a built-in pull-up resistor
	EN & MR logic control conditions	С	: EN1, EN2 Pins are not pulled up internally, MR pin has a built-in pull-up resistor
		D	: EN1, EN2 pins have built-in pull-up resistors, MR pin are not pulled up internally
	Set Voltage Combinations	01 ~	: Based on Torex Standard Product Number
	Package	Z	: QFN-20
	Device Orientation	R	: Embossed tape, Standard feed
	Device Orientation	L	: Embossed tape, Reverse feed

### **BLOCK DIAGRAM**



### ABSOLUTE MAXIMUM RATINGS

Ta=25°C

PARAMETER		SYMBOL	RATINGS	UNITS
P_V <sub>DD1</sub> ·P_V <sub>DD2</sub> F	Pin Voltage	P_VDD1, P_VDD2	-0.3~6.5	V
V <sub>OUT1</sub> •V <sub>OUT2</sub> Pir	n Voltage	VOUT1, VOUT2	-0.3~6.5	V
Cd Pin Vol	tage	VCd	-0.3~P_V <sub>DD1.2</sub> +0.3	V
V <sub>DOUT</sub> Pin Ve	oltage	V <sub>DOUT</sub>	-0.3~6.5	V
V <sub>DOUT</sub> Pin Current		Idout	10	mA
EN1·EN2·MR F	in Voltage	VEN1, VEN2, VMR	-0.3~6.5	V
LX1-LX2 Pin	Voltage	VLx1, VLx2	-0.3~P_V <sub>DD1.2</sub> +0.3	V
LX1 · LX2 Pin	Current	ILx1, ILx2	1500	mA
Power Dissipation		Pd (Free air)	300	mW
	QFN-20	Pd (Wiring on PCB)	1000	11100
Operating Temperature Range		Topr	-40 ~ +85	٥C
Storage Temperature Range		Tstg	-55 ~ +125	°C

\* P\_V\_DD1 . 2 stands for P\_V\_DD1=P\_V\_DD2

 $A\_V_{SS}=P\_V_{SS1}=P\_V_{SS2}=0V$ 

### **ELECTRICAL CHARACTERISTICS**

#### XC9515AB04xx

		<sub>JT2</sub> =3.3V, f <sub>OSC</sub> =1MHz, EN1 · 2 Pull-up inside)			1		Ta =25°(
PARAMETER	SYMBOL	CONDITIONS	MIN.	TYP.	MAX.	UNITS	CIRCUIT
Input Voltage	Vin		4.5	5.0	5.5	V	-
Output Voltage 1	Vout1	Connected to the external components, P_V <sub>DD1.2</sub> =V <sub>EN1</sub> =V <sub>EN2</sub> =0V, I <sub>OUT1</sub> =30mA	1.470	1.500	1.530	V	1
Output Voltage 2	Vout2	Connected to the external components, P_V <sub>DD1-2</sub> =V <sub>EN2</sub> =V <sub>EN1</sub> =0V, I <sub>OUT2</sub> =30mA	3.234	3.300	3.366	V	1
Maximum Output Current 1 · 2 (*1)	IOUTMAX1 IOUTMAX2		800	_	-	mA	1
Current Limit 1-2	I LIM1 ▪ I LIM 2		1000	_		mA	2
Oscillation Frequency	f <sub>osc</sub>	Connected to the external components, IouT=10mA	0.85	1.00	1.15	MHz	1
Maximum Duty Cycle	MAXDTY	V <sub>OUT1</sub> =V <sub>OUT2</sub> =0V	100	-	_	%	2
Minimum Duty Cycle	MINDTY	V <sub>OUT1</sub> =V <sub>OUT2</sub> =V <sub>IN</sub>		—	0	%	2
Efficiency 1 <sup>(*2)</sup>	EFFI1	Connected to the external components, $P_V_{DD1\cdot2}=V_{EN1}=5.0V$ , $V_{EN2}=0V$ , $V_{OUT1}=1.5V$ , $I_{OUT}=1200$ mA	-	89	_	%	1
Efficiency 2 <sup>(*2)</sup>	EFFI2	Connected to the external components, $P_V_{DD1.2}=V_{EN2}=5.0V$ , $V_{EN1}=0V$ , $V_{OUT2}=3.3V$ , $I_{OUT2}=200mA$	Ι	94	_	%	1
LX1·2 "H" ON Resistance	Rlx1h•Rlx2h	V <sub>OUT1</sub> =V <sub>OUT2</sub> =0V, ILx1=ILx2=100mA <sup>(*3)</sup>	-	0.35 <sup>(*4)</sup>	-	Ω	3
LX1-2 "L" ON Resistance	RLX1L·RLX2L		-	0.35 <sup>(*4)</sup>	-	Ω	_
Integral Latch Time 1.2		LX1 and LX2 are pulled down by a resistor of 200 Ω V <sub>OUT1</sub> =Setting Voltage × 0.9, V <sub>OUT2</sub> = Setting Voltage × 0.9 <sup>(15)</sup>	_	6	_	ms	Ī
Soft-Start Time 1.2	t <sub>ss1</sub> • t <sub>ss2</sub>	Time until EN1, EN2 or both pins changes from 0V to $V_{IN}$ and voltage becomes $V_{OUT1-2} \times 0.95$ , $I_{OUT1-2}$ =10mA	-	1.3	_	ms	1
EN1·2 "H" Level Voltage	Ven1h• Ven2h	V <sub>OUT1</sub> =V <sub>OUT2</sub> =0V Voltage which LX1 or LX2 becomes "H" <sup>(°6)</sup>	1.2	_	5	V	4
EN1·2 "L" Level Voltage	Ven1l• Ven2l	V <sub>OUT1</sub> =V <sub>OUT2</sub> =0V Voltage which LX1 or LX2 becomes "L" <sup>("6)</sup>	AVSS	_	0.4	V	4
EN1·2 "H" Level Current	IEN1H·IEN2H	P_V <sub>DD1.2</sub> =V <sub>EN1</sub> =V <sub>EN2</sub> =5.5V	_		0.1 <sup>(*8)</sup>	μA	4
EN1·2 "L" Level Current	IEN1L·IEN2L	P_V <sub>DD1.2</sub> =5.5V, V <sub>EN1</sub> =V <sub>EN2</sub> =0V	_	-6 <sup>(*8)</sup>	_	μA	4
LX1·2 "H" Leakage Current (*7)	Ileak1h• Ileak2h	P_V <sub>DD1·2</sub> =V <sub>LX1</sub> =V <sub>LX2</sub> =5.5V, V <sub>EN1</sub> =V <sub>EN2</sub> =0V	_	-	1.0 <sup>(*9)</sup>	μA	4
LX1·2 "L" Leakage Current	Ileak1l• Ileak2l	P_V <sub>DD1·2</sub> =5.5V, V <sub>LX1</sub> =V <sub>LX2</sub> =V <sub>EN1</sub> =V <sub>EN2</sub> =0V	-3.0 <sup>(*9)</sup>	_	_	μA	4

Test Conditions :

\*P\_V\_DD1.2 stands for P\_V\_DD1=P\_V\_DD2 \*\*Unless otherwise stated, P\_V\_DD1.2=5V, V\_{EN1}=V\_{EN2}=P\_V\_{DD1.2} \*\*\* A\_V\_{SS}=P\_V\_{SS1}=P\_V\_{SS2}=0V

NOTE :

\*1 : When the difference between the input and the output is small, some cycles may be skipped completely before current maximizes. If current is further pulled from this state, output voltage will decrease because of P-ch driver ON resistance.

\*2 : EFFI = { ( output voltage x output current ) / ( input voltage x input current) } x 100

\*3 : On resistance ( )= (V<sub>IN</sub> - Lx pin measurement voltage) / 100mA

\*4 : Designed value.

\*5 : Time until it short-circuits LX1 (LX2 in the side of 2CH) with GND via 1 of resistor from an operational state and is set to Lx=0V from current limit pulse generating.

\*6 : "H" is judged as "H">V $_{IN}$ -0.1V, "L" is judged as "L"<0.1V.

\*7 : When temperature is high, a current of approximately 20  $\mu$  A (maximum) may leak.

\*8 : Current which EN1 and EN2 are measured separately.

\*9 : Lead current which LX1 and LX2 are measured separately.

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## ELECTRICAL CHARACTERISTICS (Continued)

XC9515AB04xx

Voltage Detector (VD) (MR pin Pull-up Inside) Block Ta								
PARAMETER	SYMBOL	CONDITIONS	MIN.	TYP.	MAX.	UNITS	CIRCUIT	
Detect Voltage	V <sub>DF(E)</sub> (*1)		VDF(T) × 0.98	VDF(T) <sup>(*2)</sup>	VDF(T) × 1.02	v	5	
Hysteresis Width	V <sub>HYS</sub>	V <sub>HYS</sub> =(V <sub>DR(E)</sub> <sup>(*3)</sup> - V <sub>DF(E)</sub> ) / V <sub>DF(E)</sub> ×100	-	5.0	1	%	-	
VD Output Current	I <sub>DOUT</sub>	$P_V_{DD1.2}=V_{DF}-0.01V$ , Apply 0.5V to $V_{DOUT}$	5.0	6.6	8.0	mA	4	
Delay Resistance	R <sub>DLY</sub>		-	2.5	-	MΩ	-	
MR "H" Level Voltage	V <sub>MRH</sub>	V <sub>DOUT</sub> ="H" Level Voltage <sup>(*3)</sup>	1.2	-	5.5	V	4	
MR "L" Level Voltage	$V_{MRL}$	V <sub>DOUT</sub> ="L" Level Voltage <sup>(*3)</sup>	AVSS	-	0.4	V	4	
MR "H" Level Current	I <sub>MRH</sub>	P_V <sub>DD1.2</sub> =V <sub>MR</sub> =5.5V	-	-	0.1	μA	4	
MR "L" Level Current	I <sub>MRL</sub>	P_V <sub>DD1.2</sub> =5.5V, V <sub>MR</sub> =0V	—	-6.0	-	μA	4	

Test Conditions :

\*  $P_V_{DD1.2}$  stands for  $P_V_{DD1}=P_V_{DD2}$ 

\*\*Unless otherwise stated, P\_V\_DD1 . \_2=5V, V\_EN1=V\_EN2= P\_V\_DD1 . \_2 \*\*\* A\_V<sub>SS</sub>=P\_V<sub>SS1</sub>=P\_V<sub>SS2</sub>=0V

NOTE :

\*1 : V<sub>DF(E)</sub>=Detect Voltage \*2 : V<sub>DR(E)</sub>=Release Voltage

\*3 : "H" is judged as "H">V\_IN-0.1V, "L" is judged as "L"<0.1V

#### XC9515AB04xx

Whole Circuit (V<sub>OUT1</sub>=1.5V, V<sub>OUT2</sub>=3.3V, f<sub>OSC</sub>=1MHz, EN1 · 2 Pull-up Inside)

Ta=25°C

							10 20 0
PARAMETER	SYMBOL	CONDITIONS	MIN.	TYP.	MAX.	UNITS	CIRCUIT
Supply Current 1	IDD1	V <sub>OUT1</sub> =V <sub>OUT2</sub> =Setting Voltage x 0.9	-	950	1500	μA	6
Supply Current 2	IDD2	$V_{OUT1}=V_{OUT2}=$ Setting Voltage x 1.1 (Oscillation stops)		75	145	μA	6
Stand-by Current	Istb	V <sub>EN1</sub> =V <sub>EN2</sub> =0V		18	33	μA	6
UVLO Detect Voltage	VUVLOF	$V_{\text{IN}}$ voltage which $V_{\text{OUT1}}\text{=}0V$ and LX pin becomes "L" $^{(*1)}$	2.4	1.8	3.0	V	2
UVLO Release Voltage	VUVLOR	$V_{\text{IN}}$ voltage which $V_{\text{OUT1}}\text{=}0V$ and LX pin becomes "H" $^{(*1)}$			3.5	V	2
Thermal Shutdown Temperature	Ttsd		_	150	-	°C	_
Thermal Shutdown Hysteresis Width	Thys		-	20	-	°C	_

Test Conditions :

\* P\_V\_DD1 .  $_2$  stands for P\_V\_DD1=P\_V\_DD2

\*\*Unless otherwise stated, P\_V\_DD1  $\cdot$  2=5V, V\_EN1=V\_EN2= P\_V\_DD1  $\cdot$  2

\*\*\* A\_V<sub>SS</sub>=P\_V<sub>SS1</sub>=P\_V<sub>SS2</sub>=0V

NOTE :

\*1 : "H" is judged "H">V<sub>IN</sub>-0.1V, "L" is judged "L"<0.1V

## ELECTRICAL CHARACTERISTICS (Continued)

#### XC9515BA06xx

PARAMETER	SYMBOL	CONDITIONS	MIN.	TYP.	MAX.	UNITS	CIRCUIT
Input Voltage	Vin		2.5		5.5	V	
Output Voltage1	Vout1	Connected to the external components, P <sub>VDD1.2</sub> =EN1, EN2=0V I <sub>OUT1</sub> =30mA	1.470	1.500	1.530	V	1
Output Voltage2	Vout2	Connected to the external components, P <sub>VDD1-2</sub> =EN2, EN1=0V I <sub>OUT2</sub> =30mA	3.234	3.300	3.366	V	1
Maximum Output Current 1 • 2 (*1)	Ioutmax1 Ioutmax2		800			mA	1
Current Limit 1-2	ILIM1 ILIM 2		1000			mA	2
Oscillation Frequency	f <sub>osc</sub>	Connected to the external components, $I_{OUT}$ =10mA	0.85	1.00	1.15	MHz	1
Maximum Duty Cycle	MAXDTY	V <sub>OUT1</sub> =V <sub>OUT2</sub> =0V	100			%	2
Minimum Duty Cycle	MINDTY	V <sub>OUT1</sub> =V <sub>OUT2</sub> =V <sub>IN</sub>			0	%	2
Efficiency 1 (*2)	EFFI1	Connected to the external components, P <sub>VDD1.2</sub> =EN1=5.0V, EN2=0V V <sub>OUT1</sub> =1.5V, I <sub>OUT1</sub> =200mA		89		%	1
Efficiency 2 (*2)	EFFI2	Connected to the external components, P <sub>VDD1·2</sub> =EN2=5.0V, EN1=0V V <sub>OUT2</sub> =3.3V, I <sub>OUT2</sub> =200mA		94		%	1
LX1-2 "H" ON Resistance	Rlx1h•Rlx2h	V <sub>OUT1</sub> =V <sub>OUT2</sub> =0V, ILx1=ILx2=100mA <sup>(*3)</sup>		0.35 <sup>(*4)</sup>		Ω	3
LX1-2 "L" ON Resistance	RLX1L·RLX2L			0.35 <sup>(*4)</sup>		Ω	-
Integral Latch Time 1.2	tlat1.tlat2	LX1 and LX2 are pulled down by a resistor of 200 $\Omega$ V <sub>OUT1</sub> = Setting Voltage × 0.9, V <sub>OUT2</sub> = Setting Voltage × 0.9 <sup>(*5)</sup>		6		ms	Ī
Soft-Start Time 1 · 2	tss1.tss2	Time until EN1, EN2 or both pins changes from 0V to $V_{IN}$ and voltage becomes $V_{OUT1.2} \times 0.95$ , $I_{OUT1.2} = 10 \text{mA}$		1.3		ms	1
EN1•2 "H" Voltage	Ven1h·Ven2h	V <sub>out1</sub> =V <sub>out2</sub> =0V Voltage which LX1 or LX2 becomes "H" <sup>(*6)</sup>	1.2		5	V	4
EN1·2 "L" Voltage	VEN1L·VEN2L	V <sub>OUT1</sub> =V <sub>OUT2</sub> =0V Voltage which LX1 or LX2 becomes "L" <sup>(*6)</sup>	AVSS		0.4	V	4
EN1-2 "H" Current	I <sub>EN1H</sub> •I <sub>EN2H</sub>	P <sub>VDD1·2</sub> =EN1=EN2=5.5V			0.1(*8)	μA	4
EN1 · 2 "L" Current	I <sub>EN1L</sub> •I <sub>EN2L</sub>	P <sub>VDD1.2</sub> =5.5V, EN1=EN2=0V	-0.1(*8)			μA	4
LX1•2 "H" Leak Current (*7)	I <sub>leak1H</sub> •I <sub>leak2H</sub>	P <sub>VDD1·2</sub> =LX1=LX2=5.5V, EN1=EN2=0V			1.0(*9)	μA	4
LX1.2 "L" Leak Current	I <sub>leak1L</sub> •I <sub>leak2L</sub>	P <sub>VDD1-2</sub> =5.5V, LX1=LX2=EN1=EN2=0V	-3.0 <sup>(*9)</sup>			μA	4

Test Conditions :

\*\*  $P_{DD1.2}$  stands for  $P_{V_{DD1}=P_{V_{DD2}}}$ \*\*Unless otherwise stated,  $P_{V_{DD1.2}=5V$ ,  $V_{EN1}=V_{EN2}=P_{V_{DD1.2}}$ \*\*\*  $A_V_{SS}=P_{V_{SS1}=P_{V_{SS2}=0V}}$ 

NOTE :

\*1 : When the difference between the input and the output is small, some cycles may be skipped completely before current maximizes. If current is further pulled from this state, output voltage will decrease because of P-ch driver ON resistance.

\*2 : EFFI = { ( output voltage x output current ) / ( input voltage x input current) } x 100

\*3 : On resistance ( )= (V<sub>IN</sub> - Lx pin measurement voltage) / 100mA

\*4 : Designed value.

\*5 : Time until it short-circuits LX1 (LX2 in the side of 2CH) with GND via 1 of resistor from an operational state and is set to Lx=0V from current limit pulse generating.

\*6 : "H" is judged as "H">V\_{IN}-0.1V, "L" is judged as "L"<0.1V.

\*7 : When temperature is high, a current of approximately 20 µ A (maximum) may leak.

\*8 : Current which EN1 and EN2 are measured separately.

\*9 : Lead current which LX1 and LX2 are measured separately.

## ELECTRICAL CHARACTERISTICS (Continued)

#### XC9515BA06xx

VD	(MR	pin	is	internally	floating
	···· ·	F			

VD (MR pin is internally floating) Ta=2							
PARAMETER	SYMBOL	CONDITIONS	MIN.	TYP.	MAX.	UNITS	CIRCUIT
Detect Voltage	V <sub>DF(E)</sub> (*1)		2.94	3.00	3.06	V	5
Hysteresis Width	VHYS	$V_{HYS} = \{V_{DR(E)} \stackrel{(^{*2})}{\longrightarrow} V_{DF(E)} \} / V_{DF(E)} \times 100$		5.0		%	-
VD Output Current	IDOUT	$P_V_{DD1.2}=V_{DF}-0.01V$ , Apply 0.5V to $V_{DOUT}$	5.0	6.6	8.0	mA	4
Delay Resistance	Rdly			2.5		MΩ	-
MR "H" Level Voltage	Vmr	V <sub>DOUT</sub> ="H" Level Voltage <sup>(*3)</sup>	1.2		5.5	V	4
MR "L" Level Voltage	Vmr	V <sub>DOUT</sub> ="L" Level Voltage <sup>(*3)</sup>	AVSS		0.4	V	4
MR "H" Level Current	Imr	P <sub>VDD1.2</sub> =MR=5.5V			0.1	μA	4
MR "L" Level Current	Imr	P <sub>VDD1.2</sub> =5.5V,MR=0V	-0.1(* 8)			μA	4

Test Conditions :

\*  $P_V_{DD1.2}$  stands for  $P_V_{DD1}=P_V_{DD2}$ 

\*\*Unless otherwise stated, P\_V<sub>DD1.2</sub>=5V, V<sub>EN1</sub>=V<sub>EN2</sub>= P\_V<sub>DD1.2</sub> \*\*\* A\_V<sub>SS</sub>=P\_V<sub>SS1</sub>=P\_V<sub>SS2</sub>=0V

NOTE :

\*1 :  $V_{DF(E)}$ =Detect Voltage

\*2 : V<sub>DR(E)</sub>=Release Voltage

\*3 : "H" is judged as "H">V $_{\mbox{\scriptsize IN}}$ -0.1V, "L" is judged as "L"<0.1V

#### XC9515BA01xx

Whole Circuit (V <sub>OUT1</sub> =1.5V, V <sub>OUT2</sub> =3.3V, f <sub>OSC</sub> =1MHz, EN1 and EN2 pins are internally floating) Ta=25 °C							
PARAMETER	SYMBOL	CONDITIONS	MIN.	TYP.	MAX.	UNITS	CIRCUIT
Supply Current 1	IDD1	V <sub>OUT1</sub> =V <sub>OUT2</sub> = Setting Voltage × 0.9		950	1500	μA	6
Supply Current 2	IDD2	V <sub>OUT1</sub> =V <sub>OUT2</sub> = Setting Voltage × 1.1 (Oscillation stops)		75	145	μA	6
Stand-by Current	Іstb	EN1=EN2=0V		5.5	11	μA	6
UVLO Detect Voltage	VUVLOF	$V_{\text{IN}}$ voltage which $V_{\text{OUT1}}\text{=}0V$ and $L_X$ pin becomes "L" $^{(*1)}$	1.5	1.8	2.1	V	2
UVLO Release Voltage	VUVLOR	$V_{\text{IN}}$ voltage which $V_{\text{OUT1}}\text{=}0V$ and $L_{X}$ pin becomes "H" $^{(^{*1})}$			2.3	V	2
Thermal Shutdown Temperature	Ttsd			150		°C	-
Thermal Shutdown Hysteresis Width	Thys			20		°C	-

Test Conditions :

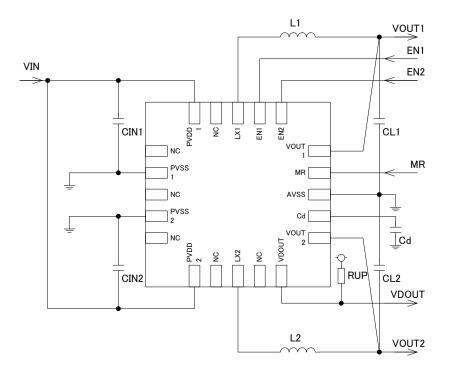
\* P\_V\_DD1 . 2 stands for P\_V\_DD1=P\_V\_DD2

\*\*\*Unless otherwise stated, P\_V\_D\_1 . \_2=5V, V\_EN1=V\_EN2= P\_V\_DD1 . \_2 \*\*\*\* A\_V\_SS=P\_V\_SS1=P\_V\_SS2=0V

NOTE :

\*1 : "H" is judged "H">V $_{\mbox{\scriptsize IN}}$ -0.1V, "L" is judged "L"<0.1V

### **TYPICAL APPRICATION CIRCUIT**



< Example of the External Components >

L1 : 4.7 µ H ( CDRH4D28C, SUMIDA )

- L2 : 4.7 µ H ( CDRH4D28C, SUMIDA )
- $C_{IN1}$  : 10  $\mu$  F ( ceramic )
- $C_{\text{IN2}}$  : 10  $\mu$  F ( ceramic )
- $C_{L1}$  : 10  $\mu$  F ( ceramic )
- $C_{\text{L2}}$  : 10  $\mu$  F ( ceramic )
- RUP : 100kΩ

### **OPERATIONAL EXPLANATION**

XC9515 series consists of a reference voltage source, ramp wave circuit, error amplifier, PWM comparator, phase compensation circuit, output voltage adjustment resistors, P-channel driver transistor, N-channel synchronous switching transistor, current limit circuit, UVLO circuit and others. The series ICs compare, using the error amplifier, the voltage of the internal voltage reference source with the feedback voltage from  $V_{OUT}$  pin through split resistors,  $R_{FB1}$  and  $R_{FB2}$ . Phase compensation is performed on the resulting error amplifier output, to input a signal to the PWM comparator to determine the turn-on time during PWM operation. The PWM comparator compares, in terms of voltage level, the signal from the error amplifier with the ramp wave from the ramp wave circuit, and delivers the resulting output to the buffer driver circuit to cause the Lx pin to output a switching duty cycle. This process is continuously performed to ensure stable output voltage. The current feedback circuit monitors the P-channel driver transistor current for each switching operation, and modulates the error amplifier output signal to provide multiple feedback signals. This enables a stable feedback loop even when a low ESR capacitor, such as a ceramic capacitor, is used, ensuring stable output voltage.

#### <Reference Voltage Source>

The reference voltage source provides the reference voltage to ensure stable output voltage of the DC/DC converter.

#### <Ramp Wave Circuit>

The ramp wave circuit determines switching frequency. The frequency is fixed internally at 1MHz. Clock pulses generated in this circuit are used to produce ramp waveforms needed for PWM operation, and to synchronize all the internal circuits.

#### <Error Amplifier>

The error amplifier is designed to monitor output voltage. The amplifier compares the reference voltage with the feedback voltage divided by the internal split resistor,  $R_{FB1}$  and  $R_{FB2}$ . When a voltage lower than the reference is fed back, the output voltage of the error amplifier increases. The gain and frequency characteristics of the error amplifier output are fixed internally to deliver an optimized signal to the mixer.

#### <Current Limit>

The current limiter circuit of the XC9515 series monitors the current flowing through the P-channel MOS driver transistor connected to the Lx pin, and features a combination of the current limit mode and the latch mode.

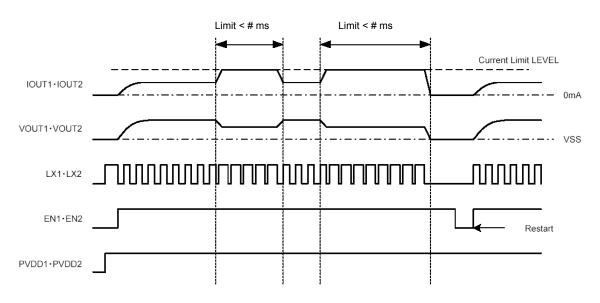
When the driver current is greater than a specific level (peak value of coil current), the current limit function operates to off the pulses from the Lx pin at any giving timing.

When the driver transistor is turned off, the limiter circuit is then released from the current limit detection state.

At the next pulse, the driver transistor is turned on. However, the transistor is immediately turned off in the case of an over current state.

When the over current is eliminated, the IC resumes its normal operation.

The IC waits for the over current state to end by repeating the steps to . If an over current state continues for a few ms and the above three steps are repeatedly performed, the IC performs the function of latching the OFF state of the driver transistor. Both two DC/DC blocks stop operations when either CH1 or CH2 of protection circuit is activated. At this time, both Lx1 and Lx2 become high impedance. Once the IC is in latch mode, operations can be resumed by either turning the IC off after letting EN1 and EN2 pins down to low level, or by restoring power. For restoring power, the IC should be turned off after P\_V<sub>DD1</sub> and P\_V<sub>DD2</sub> voltages drop below the low level of EN1 and EN2 pin. ) The latch operation can be released from the current limit detection state because of the circuit's noise. Also, depending on the state of the PC Board, latch time may become longer and latch operation may not work. In order to avoid the effect of noise, the board should be laid out so that capacitors are placed as close to the chip as possible.



### **OPERATIONAL EXPLANATION (Continued)**

#### <Thermal Shutdown>

For protecting the IC from heat damage, the thermal shutdown circuit monitors the chip temperature. When the chip temperature reaches 150 , the thermal shutdown circuit operates and the driver transistor will be set to OFF. As the chip temperature drops to 130 by stopping current flow, the soft-start function operates to turn the output on.

#### <Short-Circuit Protection>

The short-circuit protection circuit monitors the FB voltage. If the output is shorted incorrectly with the ground, the short-circuit protection circuit operates and turns the driver transistor off to latch when the FB voltage becomes less than half of the setting voltage. Both two DC/DC blocks stop operations when either CH1 or CH2 of protection circuit is activated. At this time, both Lx1 and Lx2 become high impedance. Once the IC is in latch mode, operations can be resumed by either turning the IC off after letting both ends of EN1 and EN2 pins down to low level, or by restoring power. (The  $P_V_{DD1}$  and  $P_V_{DD2}$  voltages should be less than the low level of the EN1 and EN2 pins when restoring power.)

#### <Soft Start Function>

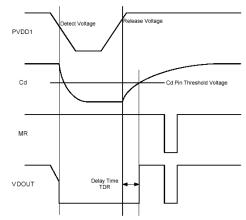
The soft-start circuit protects against inrush current, when the power is switched on, and also to protect against voltage overshoot. It should be noted, however, that this circuit does not protect the load capacitor (CL) from inrush current. With the Vref voltage limited and depending upon the input to the error amps, the operation maintains a balance between the two inputs of the error amps and controls the EXT1 pin's ON time so that it doesn't increase more than is necessary.

#### <UVLO Circuit>

When the VIN pin voltage becomes 1.8V (TYP.) or lower (for XC9515A, 2.7V or lower), the P-channel output driver transistor is forced OFF to prevent false pulse output caused by unstable operation of the internal circuitry. When the VIN pin voltage becomes 1.9V (TYP.) or higher (for XC9515A, 3.0V or lower), switching operation takes place. By releasing the UVLO function, the IC performs the soft-start function to initiate output startup operation.

#### <Voltage Detector Block>

The series' detector function monitors the voltage divided by resistors connected to the P\_VDD1 pin, as well as monitoring the voltage of the internal reference voltage source via the comparator. Because of hysteresis at the detector function, output at the  $V_{Dout}$  pin will invert when the sense pin voltage of the detector block (P\_VDD1) increases above the release voltage (105% of the detect voltage). The output configuration of the V<sub>Dout</sub> pin is N-channel open drain, therefore, a pull-up resistor is required. The voltage detector block has a manual reset (MR) pin. By setting the MR pin at low level, the V<sub>Dout</sub> pin is forced to be at low level.



By connecting a capacitor (Cd) to the Cd pin, the XC9515 series can set a delay time to VDOUT pin's output signal when releasing voltage. The delay time can be calculated from the internal resistance, Rdelay (2.5M fixed TYP.) and the value of Cd as per the following equation. As selecting the capacitor (Cd), the delay time can be set freely.

#### $t_{DR}$ (Delay time) = Cd x Rdelay x 0.69

Release Delay		Ta=25 °C
Delay Capacity Cd [ µ F]	Release Delay t <sub>DR</sub> (TYP.) [ms]	Release Delay t <sub>DR</sub> (MIN. ~ MAX.) [ms]
0.01	17	10~24
0.022	38	23~53
0.047	81	49 ~ 113
0.1	173	103 ~ 242
0.22	380	228 ~ 532
0.47	811	487 ~ 1135
1	1725	1035 ~ 2415

### NOTES ON USE

- 1. Please use this IC within the stated maximum ratings. The IC is liable to malfunction should the ratings be exceeded.
- Please apply the same electrical potential to the P\_V<sub>DD1</sub> and P\_V<sub>DD2</sub> pins. Even where either CH1 or CH2 is used, both P\_V<sub>DD1</sub> and P\_V<sub>DD2</sub> pins should have the same electrical potential. Applying the electrical potential to only one side causes malfunction. Also the same electrical potential should be applied to the P\_V<sub>SS1</sub>, P\_V<sub>SS2</sub> and A\_V<sub>SS</sub> pins.
- 3. The XC9515 series is designed for use with ceramic output capacitors. If, however, the potential difference between dropout voltage or output current is too large, a ceramic capacitor may fail to absorb the resulting high switching energy and the output could be unstable. If the input-output potential difference is large, use a larger output capacitor to compensate for insufficient capacitance.
- 4. When the peak current, which exceeds limit current flows within the specified time, the built-in driver transistor is turned off (the integral latch circuit). During the time until it detects limit current and before the built-in transistor can be turned off, the current for limit current flows; therefore, care must be taken when selecting the rating for the coil.
- 5. When the input voltage is low, limit current may not be reached because of voltage falls caused by ON resistance or serial resistance of the coil.
- 6. Since the potential difference for input voltage has occurred to the both ends of a coil, the time changing rate of the coil current is large when the P-channel driver transistor is ON. On the other hand, since the V<sub>OUT</sub> pin short-circuits to the GND when the N-channel transistor is ON and there is almost no potential difference of the coil both ends, the time changing rate of the coil current becomes very small.

This operation is repeated and the delay time of the circuit also influences, therefore, the coil current is converged on the current value beyond the amount of current which should be restricted essentially.

The short-circuit protection does not operate during the soft-start time. As soon as the soft-start time finishes, the short-circuit protection starts to operate and the circuit becomes disable.

The delay time of the circuit also influences when step-down ratio is large, as the result, a current more than over current limit may flow. Please do not exceed the absolute maximum ratings of the coil.

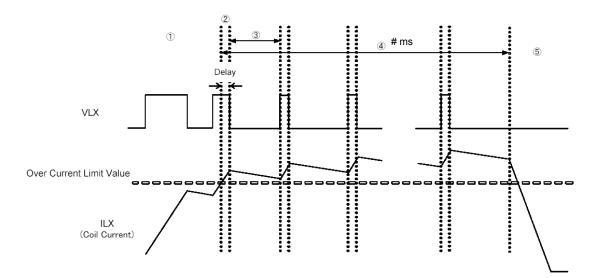
A current flows to the driver transistor up to the current limit  $(I_{LIM})$ .

For the delay time of the circuit, a current more than the  $I_{LIM}$  flows after the  $I_{LIM}$  decide until the P channel driver transistor turns off.

Time changing rate of the coil current becomes very small because there is no potential difference between both ends of the coil.

The Lx pin oscillates a narrow pulse during the soft-start time because of the current limit.

The circuit is latched since the short-circuit protection operates and the P-channel driver transistor is turned off.



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## NOTES ON USE (Continued)

- 7. Driving current below the minimum operating voltage may lead malfunction to the UVLO circuit because of the noise.
- 8. Depending on the PC board condition, the latch function may be released from limit current detection state and the latch time may extend or fail to reach the latch operation. Please locate the input capacitance as close to the IC as possible.
- 9. Spike noise and ripple voltage arise in a switching regulator as with a DC/DC converter. These are greatly influenced by external component selection, such as the coil inductance, capacitance values, and board layout of external components. Once the design has been completed, verification with actual components should be done.
- 10. With the DC/DC converter block of the IC, the peak current of the coil is controlled by the current limit circuit. Since the peak current increases when dropout voltage or load current is high, current limit starts operating, and this can lead to instability. When peak current becomes high, please adjust the coil inductance value and fully check the circuit operation. In addition, please calculate the peak current according to the following formula:

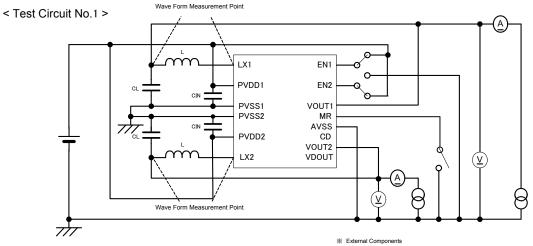
 $\begin{array}{l} \mbox{Peak current: Ipk = (VIN - V_{OUT}) x OnDuty / (2 x L x fosc) + I_{OUT} \\ \mbox{L: Coil Inductance Value, } f_{OSC} : Oscillation Frequency \end{array}$ 

- 11. When the load current is light in PWM control, very narrow pulses will be outputted, and there is the possibility that some cycles may be skipped completely.
- 12. When the difference between VIN and VOUT is small, and the load current is heavy, very wide pulses will be outputted and there is the possibility that some cycles may be skipped completely.
- 13. If the power input pin voltage is assumed to decrease rapidly (ex. from 6.0V to 0V) at the release of the operation although delay capacitance (Cd) pin is connected, please connect an Shottky barrier diode between the power input (P\_V<sub>DD1</sub>) pin and the delay capacitance (Cd) pin.
- 14. Please connect a pull-up resistor with 100 to  $200 k\Omega$  to the output pin of the voltage detector block (V<sub>DOUT</sub>).
- 15. The delay time of the voltage detector block in heavy load may extend because of the noise of the DC/DC block. Precipitous and large voltage fluctuation at the power input pin may cause malfunction of the IC.
- 16. Use of the IC at voltages below the minimum operating voltage may lead the output voltage drop before achieving over current limit.
- 17. When P\_VDD1 and P\_VDD2 power supply pins and EN1 and EN2 enable pins are in undefined states, the latch protection circuit may not be reset so that the IC operation does not start correctly. Power supply and enable pins (EN1,EN2) should be grounded before starting the IC operation.
  [Undefined state conditions for each pin]
  P\_V<sub>DD1</sub>=P\_V<sub>DD2</sub>=0.1V ~ 1.2V
  V<sub>EN1</sub>=V<sub>NE2</sub>= 0.4V ~ 1.2V
- 18. UVLO function works even if when V<sub>IN</sub> input voltage falls below the UVLO voltage in very short time period like a few ten nanoseconds.

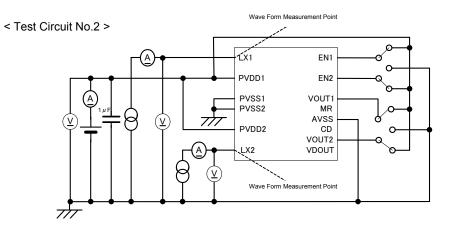
Instruction on Pattern Layout

- 1. In order to stabilize VIN's voltage level, we recommend that a by-pass capacitor (CIN1 and CIN2) be connected as close as possible to the P\_V<sub>DD1</sub> P\_V<sub>DD2</sub> pins and P\_V<sub>SS1</sub> P\_V<sub>SS2</sub> pins.
- 2. Please mount each external component as close to the IC as possible.
- 3. Wire external components as close to the IC as possible and use thick, short connecting traces to reduce the circuit impedance.
- 4. Make sure that the V<sub>SS</sub> traces are as thick as possible, as variations in the V<sub>SS</sub> potential caused by high V<sub>SS</sub> currents at the time of switching may result in instability of the DC/DC converter.

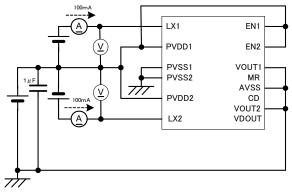
### **TEST CIRCUITS**



 $\begin{array}{ll} \mathsf{L} & : 4.7\,\mu\,\mathsf{H}(\mathsf{CDRH4D28C}:\mathsf{SUMIDA})\\ \mathsf{CIN} & : 10\,\mu\,\mathsf{F}\ (\mathsf{ceramic})\\ \mathsf{CL} & : 10\,\mu\,\mathsf{F}\ (\mathsf{ceramic}) \end{array}$ 

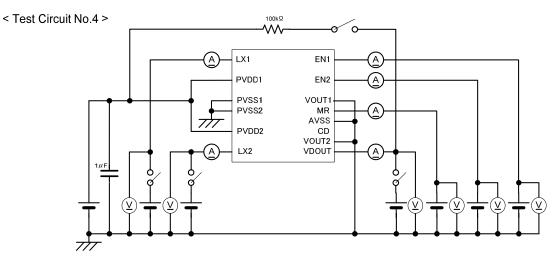


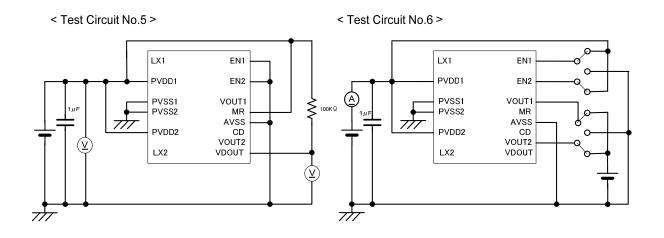
< Test Circuit No.3 >

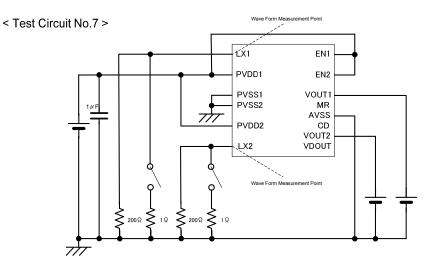


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## **TEST CIRCUITS (Continued)**



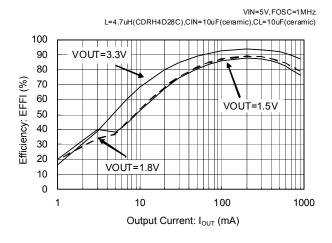




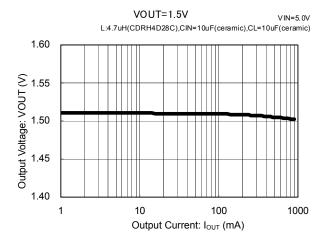


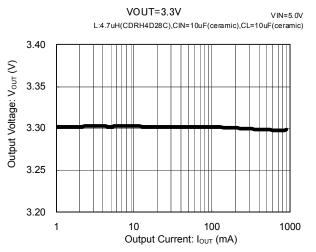
## TYPICAL PERFORMANCE CHARACTERISTICS

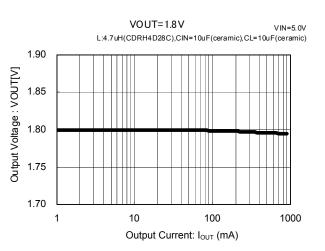
#### (1) Efficiency vs. Output Current



#### (2) Output Voltage vs. Output Current

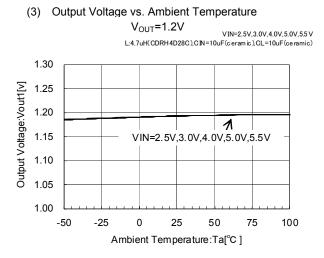




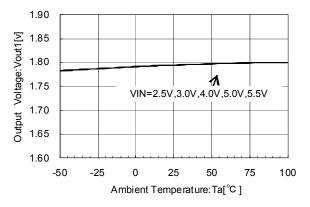


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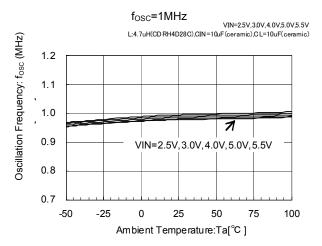
## TYPICAL PERFORMANCE CHARACTERISTICS (Continued)



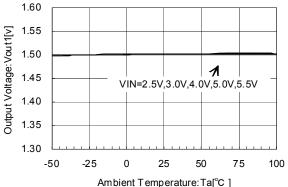




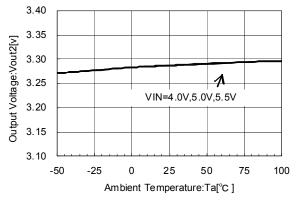
(4) Oscillation Frequency vs. Ambient Temperature







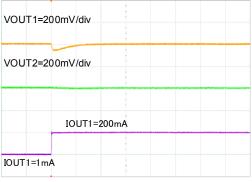




## TYPICAL PERFORMANCE CHARACTERISTICS (Continued)

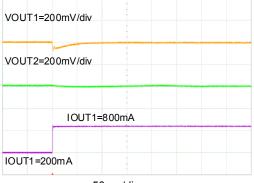
#### (5) Load Transient Response

 $V_{\text{IN}}\text{=}5V, V_{\text{OUT1}}\text{=}1.5V, V_{\text{OUT2}}\text{=}3.3V, f_{\text{OSC}}\text{=}1MHz$ 

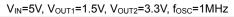


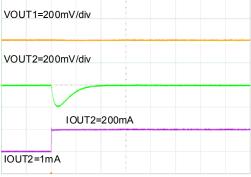


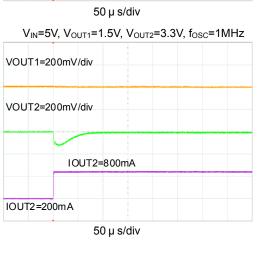
V<sub>IN</sub>=5V, V<sub>OUT1</sub>=1.5V, V<sub>OUT2</sub>=3.3V, f<sub>OSC</sub>=1MHz

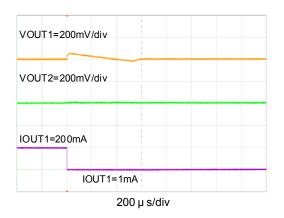


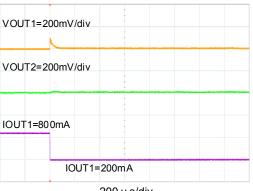
50 µ s/div



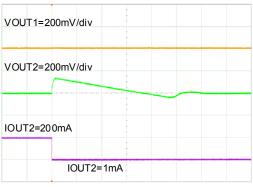




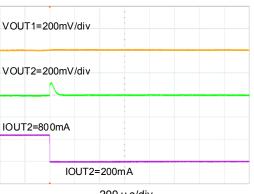




200 µ s/div









### PACKAGING INFORMATION

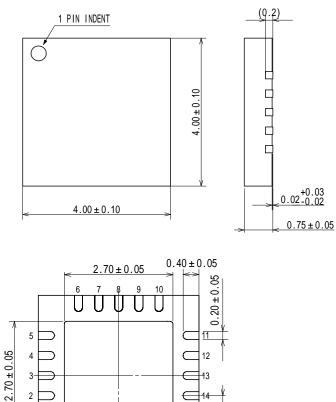
QFN-20

3-

2

1 

7



43

44

15 5) .0

 $\equiv$ 

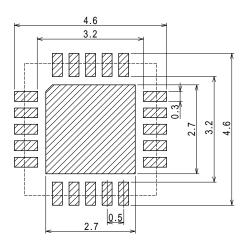
 $\in$ 

Unit: mm

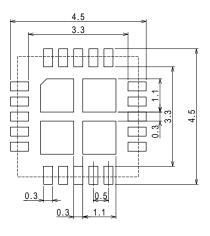
\*The solder filet may not be formed because of no plating at side.

QFN-20 Reference Pattern Layout

20 19 18 17 16



#### QFN-20 Reference Metal Mask Design

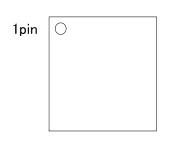


Thickness of solder paste :  $120 \,\mu$  m (reference)

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### MARKING RULE

QFN-20



QFN-20 (TOP VIEW) Standard Product

Represent product series

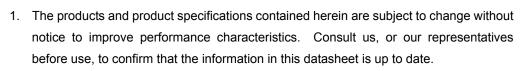
MARK			PRODUCT SERIES	
			PRODUCT SERIES	
5	1	5	XC9515*****	

Represents integer number of setting voltage

MARK				PRODUCT SERIES
				FRODUCT SERIES
0	0	0	1	XC95150001**

Represents production lot number

Order of 01, ...09, 10, 11, ...99, 0A, ...0Z, 1A, ...9Z, A0, ...Z9, AA, ...ZZ. (G, I, J, O, Q, W excepted) \*No character inversion used.



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